

# QUERY CONTROL FORM

Application No. 09/865,046 Prepared by KW  
 Examiner-GAU Chaudhury-2871 Date 2/5/2004  
 No. of queries 1

## RTIS USE ONLY

Tracking Number 05877730  
 Week Date 12/15/2003  
IFW

### JACKET

a. Serial No.	f. Foreign Priority	k. Print Claim(s)	p. <u>PTO-1449</u>
b. Applicant(s)	g. Disclaimer	l. Print Fig.	q. PTOL-85b
c. Continuing Data	h. Microfiche Appendix	m. Searched Column	r. Abstract
d. PCT	i. Title	n. PTO-270/328	s. Sheets/Figs
e. Domestic Priority	j. Claims Allowed	o. PTO-892	t. Other

### SPECIFICATION

a. Page Missing  
 b. Text Continuity  
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 g. Brief Description  
 h. Sequence Listing  
 i. Appendix  
 j. Amendments  
 k. Other

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### CLAIMS

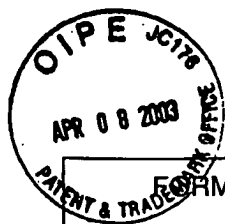
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### RESPONSE

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FORM HDP-1449 (Based on Form PTO-1449)

**PATENT AND TRADEMARK OFFICE**  
**INFORMATION DISCLOSURE CITATION**  
(Use several sheets if necessary)

Sheet 1 of 1

ATTORNEY DOCKET No.

SERIAL No.

9319S-000215

09/865,046

APPLICANT

Manabu Hanakawa

FILING DATE

GROUP

May 24, 2001

2871

**U.S. PATENT DOCUMENTS**

Ref. D sig.	Examiner's Initials	Document Number	Date	Name	Class/ Subclass	(If appropriate) Filing Date
1.						

**FOREIGN PATENT DOCUMENTS**

Ref. D sig.	Examiner's Initials	Document Number	Date	Country	Class/ Subclass	Translation * Yes	No
1.		09-179116	11.07.1997	JAPAN		X	

**OTHER DOCUMENTS (including Author, Title, Date, Pertinent Pages, etc.)**

Ref. Desig.	Examiner's Initials	
1.		Communication from Korean Intellectual Property Office

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